Search Notes

Application/Control No.	Applicant(s)/Patent unc Reexamination	pplicant(s)/Patent under eexamination	
10/721,956	KIM, DUK-YONG		
Examiner	Art Unit		
Christian A. Hannon	2685		

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted W/ Quodhian Vuonos	41406	4